

Search Notes



Application/Control No.

10/500,736

Examiner

Sang Y. Paik

Applicant(s)/Patent under Reexamination

KACHI ET AL.

Art Unit

3742

SEARCHED

Class	Subclass	Date	Examiner
219	443.1 444.1 390		
392	418		
118	724 725		
Updated on 5/12/06 1P			

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
GATT TEST RETURNED	8/24/05	JP